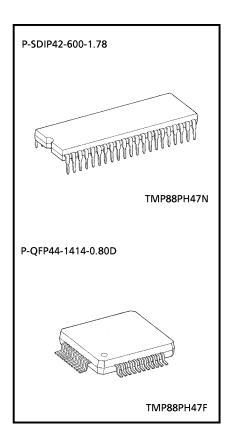
CMOS 8-Bit Microcontroller

TMP88PH47N, TMP88PH47F

The 88PH47 is a One-Time PROM microcontroller with low-power 514 Kbits (16 Kbytes + 256 bytes) electrically programmable read only memory for the 88CH47 system evaluation. The 88PH47 is pin compatible with the 88CH47. The operations possible with the 88CH47 can be performed by writing programs to PROM. The 88PH47 can write and verify in the same way as the TC571000 using an adaptor socket and an EPROM programmer.

Part No.	ОТР	RAM	Package	Adaptor Soket
TMP88PH47N	16 Kbytes	F12 Kh. +	P-SDIP42-600-1.78	BM11167
TMP88PH47F	16 Kbytes	512 Kbytes	P-QFP44-144-0.80D	BM11168



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For a discussion of how the reliability of microcontrollers can be predicted, please refer to Section 1.3 of the chapter entitled Quality and Reliability Assurance/Handling Precautions.

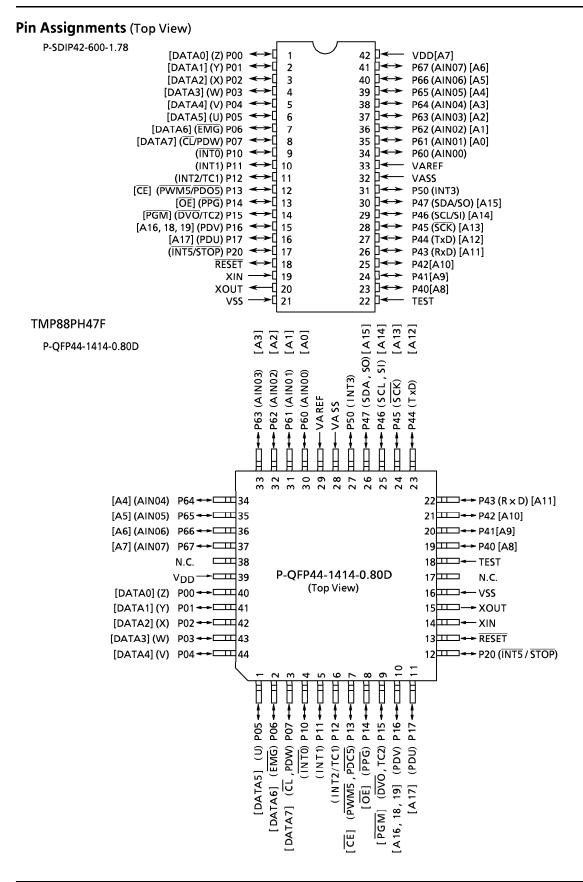
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Pin Function

The 88PH47 has two modes: MCU and PROM.

(1) MCU mode

In this mode, the 88PH47 is pin compatible with the 88CH47 (fix the TEST pin at "L" level).

(2) PROM mode

Pin Name (PROM mode)	Input/Output	Functions	Pin Name (MCU mode)			
A17			P17			
A16, A18, A19			P16			
A15 to A8	Input	PROM address inputs	P47 to P40			
A7 to A0			P67 to P60			
D7 to D0	I/O	PROM data input/outputs	P07 to P00			
CE		Chip enable signal input (active low)	P13			
ŌĒ	Input	Output enable signal input (active low)	P14			
PGM		Program enable signal input	P15			
VPP		+ 12.75 V/5 V (Program supply voltage)	TEST			
vcc	Power suppluy	+ 6.25 V/5 V	VDD			
GND		0 V	VSS			
P37 to P30						
P47 to P41		Pull-up with resistance for input processing				
P54 to P50						
P11	I/O	PROM mode setting pin. Be fixed at "H" level.				
P12, P10						
P20		PROM mode setting pin. Be fixed at "L" level.				
RESET						
XIN	Input					
хоит	Output	Connect an 16 MHz oscillator to stabilize the internal state.				
VAREF	D	OV(GND)				
VASS	Power Suppluy	0 V (GND)				

Operational Description

The following explains the 88PH47 hardware configuration and operation. The configuration and functions of the 88PH47 are the same as those of the 88CH47, except in that a one-time PROM is used instead of an on-chip mask ROM.

1. OPERATING MODE

The 88PH47 has two modes: MCU and PROM.

1.1 MCU mode

The MCU mode is activated by fixing the TEST/VPP pin at "L" level.

In the MCU mode, operation is the same as with the 88CH47 (the TEST/VPP pin cannot be used open because it has no built-in pull-down resistance).

1.1.1 Program Memory

The 88PH47 has a 16K bytes (addresses 4000_H to $07FFF_H$ in the MCU mode, addresses 0000_H to $3FFF_H$ in the PROM mode) and 256 bytes (addresses $FFF00_H$ to $1FFFF_H$ in the PROM mode) of program memory (OTP).

If using 88PH47 for system evaluation of 88CH47, write the program to the program storage area shown in Figure 1-1.

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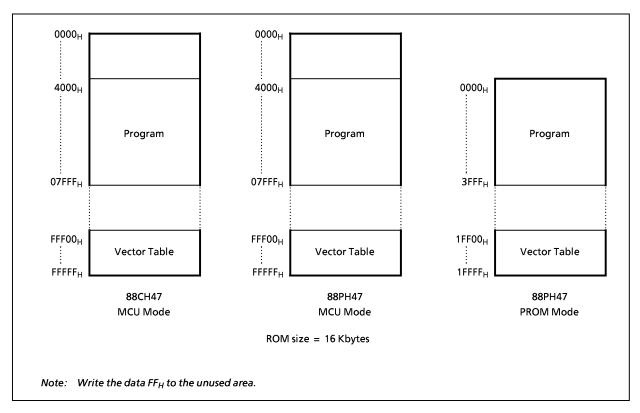


Figure 1-1. Program Memory Area

Electrical Characteristics

Absolute Maximum Ratings

 $(V_{SS} = 0 V)$

Parameter	Symbol	Pins	Ratings	Unit
Supply Voltage	V_{DD}		- 0.3 to 6.5	V
Program Voltage	V _{PP}	TEST/VPP	- 0.3 to 13.0	٧
Input Voltage	V _{IN}		- 0.3 to V _{DD} + 0.3	٧
Output Voltage	V _{OUT1}	RESET, Tri-state port	- 0.3 to V _{DD} + 0.3	٧
	V _{OUT2}	Port P20, Sink open drain port	- 0.3 to 5.5	V
	I _{OUT1}	Ports P1, P2, P4, P5, P6	3.2	
Output Current	I _{OUT2}	Port P0	20	mA
Output Current Output Current	I _{OUT3}	Port P3	30	
	Σl _{OUT1}	Ports P1, P2, P4, P5, P6	120	_
Output Current	Σl _{OUT2}	Port P0	60	mA
De la Distantia (T 7000)		TMP88PH47N	600	
Power Dissipation [Topr = 70°C]	PD	TMP88PH47F	350	mW
Soldering Temperature (time)	Tsld		260 (10 s)	°C
Storage Temperature	Tstg		– 55 to 125	°C
Operating Temperature	Topr		- 40 to 85	°C

Note: The absolute maximum ratings are rated values which must not be exceeded during operation, even for an instant. Any one of the ratings must not be exceeded. If any absolute maximum rating is exceeded, a device may break down or its performance may be degraded, causing it to catch fire or explode resulting in injury to the user. Thus, when designing products which include this device, ensure that no absolute maximum rating value will ever be exceeded.

Recommended Opeating ConditionS

 $(V_{SS} = 0 \text{ V}, \text{ Topr} = -40 \text{ to } 85^{\circ}\text{C})$

Parameter	Symbol	Pins	Co	Conditions		Max	Unit
Supply Voltage	V _{DD}		fc = 16 MHz	NORMAL mode	4.5	5.5	v
			STOP mode		2.0		
	V _{IH1}	Except hysteresis input	V _{DD} ≥ 4.5 V V _{DD} < 4.5 V		V _{DD} × 0.70		
Input High Voltage	V _{IH2}	Hysteresis input			$V_{DD} \times 0.75$	V_{DD}	V
	V _{IH3}				$V_{DD} \times 0.90$		
	V _{IL1}	Except hysteresis input		> 1 F V		$V_{DD} \times 0.30$	
Input Low Voltage	V_{IL2}	Hysteresis input	V _{DD} ≧4.5 V		0	$V_{DD} \times 0.25$	V
	V _{IL3}		V _{DD} <4.5 V			V _{DD} × 0.10	
Clock Frequency	fc	XIN, XOUT	V _{DD} =	= 4.5 to 5.5 V	8.0	16.0	MHz

Note 1: The recommended operating conditions for a device are operating conditions under which it can be guaranteed that the device will operate as specified. If the device is used under operating conditions other than the recommended operating conditions (supply voltage, operating temperature range, specified AC/DC values etc.), malfunction may occur. Thus, when designing products which include this device, ensure that the recommended operating conditions for the device are always adhered to.

Note 2: Clock frequency fc: The condition of supply voltage range is the value in NORMAL and IDLE modes.

D.C. Characteristics

 $(V_{SS} = 0 \text{ V}, \text{ Topr} = -40 \text{ to } 85^{\circ}\text{C})$

Parameter	Symbol	Pins	Conditions	Min	Тур.	Max	Unit
Hysteresis Voltage	V _{HS}	Hysteresis inputs		_	0.9	-	V
	I _{IN1}	TEST					
Input Current	I _{IN2}	Sink open drain, Tri-state ports	$V_{DD} = 5.5 \text{ V}$ $V_{IN} = 5.5 \text{ V/0 V}$	_	_	± 2	μΑ
	I _{IN3}	RESET, STOP	V - 5.5 476 4				
Invest Desister (*)	R _{IN}	TEST with pull-down		20	70	170	I.O
Input Resistor (*)	R _{IN}	RESET		90	220	510	kΩ
Output Leakage Current	l _{OL}	Sink open drain, Tri-state ports	V _{DD} = 5.5 V, V _{OUT} = 5.5 V/0 V	-	-	± 2	μΑ
Output High Voltage	V _{OH}	Tri-state ports	$V_{DD} = 4.5 \text{ V}, \ I_{OH} = -0.7 \text{ mA}$	4.1	_	-	V
	I _{OL1}	Except XOUT, Ports P0, P3.	$V_{DD} = 4.5 \text{ V}, \ V_{OL} = 0.4 \text{ V}$	_	1.6	ı	A
Output Low Current	I _{OL2}	Port P0	$V_{DD} = 4.5 \text{ V}, \ \ V_{OL} = 1.0 \text{ V}$	6	10	-	mA
Supply Current in NORMAL Mode			V _{DD} = 5.5 V	_	32	40	mA
Supply Current in IDLE Mode			$V_{IN} = 5.3 \text{ V}/0.2 \text{ V}$ fc = 16.0 MHz	_	24	30	mA
Supply Current in STOP Mode			$V_{DD} = 5.5 \text{ V}$ $V_{IN} = 5.3 \text{ V}/0.2 \text{ V}$	-	0.5	20	μΑ

Note 1: Typical values show those at Topr = 25° C, $V_{DD} = 5 V$.

Note 2: Input Current I_{IN1} , I_{IN3} ; The current through registor is not included, when the input resistor (pull-up or pull-down) is contained.

Note 3: IDD except I_{REF}.

AD Conversion Characteristics

 $(Topr = -40 \text{ to } 85^{\circ}C)$

		Conditions		n Typ.				
Parameter	Symbol		Min		A DCDR1	ADCDR2		Unit
			ADCDR1 ACK = 0 ACK = 1 VDD - 1.0 - VDD VSS - 1.0 VASS - VAREF - 0.5 1.0 - ± 1 ± 3 ± 2					
Analag Reference Voltage	V_{AREF}		V _{DD} – 1.0	_	V _{DD}		.,	
Analog Reference Voltage	V _{ASS}	V _{AREF} – V _{ASS} ≧ 3.5 V	V _{SS}	1	1.0			V
Analog Input Voltage	V _{AIN}		V _{ASS}	_		V_{AREF}		V
Analog Supply Current	I _{REF}	$V_{AREF} = 5.5 \text{ V},$ $V_{ASS} = 0.0 \text{ V}$	_	0.5		1.0		mA
Non-Linearity Error			_	_	± 1	± 3	± 2	
Zero Point Error		$V_{DD} = 5.0 \text{ V}, V_{SS} = 0.0 \text{ V}$	_	1	± 1	± 3	± 2	
Full Scale Error		V _{AREF} = 5.000 V V _{ASS} = 0.000 V		_	± 1	± 3	± 2	LSB
Total Error			_		± 2	± 6	± 4	

Note 1: ADCDR1: 8-bit AD conversion result (1LSB = $\Delta V_{AREF}/256$)

ADCDR2: 10-bit AD conversion result (1LSB = ΔV_{AREF} /1024)

Note 2: Total error includes all errors except quantization error.

A.C. Characteristics

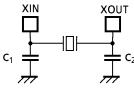
 $(V_{SS} = 0 \text{ V}, V_{DD} = 4.5 \text{ to } 5.5 \text{ V}, Topr = -40 \text{ to } 85^{\circ}\text{C})$

Parameter	Symbol	Conditions	Min	Тур.	Max	UNIT
Machine Cycle Time	NORMAL mode		0.25		٥٤	
Machine Cycle Time	tcy	IDLE mode	0.23	- 0.5		μS
"H" Level Clock Pulse Width	t _{WCH}	For external clock operation	31.25		62.5	
"L" Level Clock Pulse Width	t _{WCL}	(XIN input)	31.25	-	02.5	ns

Recommended Oscillating Conditions

 $(V_{SS} = 0 \text{ V}, V_{DD} = 4.5 \text{ to } 5.5 \text{ V}, Topr = -40 \text{ to } 85^{\circ}\text{C})$

Parameter	Oscillator	Oscillation	Recommended Oscillator	Recommended Constant		
rarameter	Frequency		Recommended Oscillator	C ₁	C ₂	
High-frequency	Ceramic Resonator	16 MHz	MURATA CSA16.00MXZ	5pF	5pF	
Oscillation			MURATA CST16.00MXW	built-in 5pF	built-in 5pF	



High-frequency Oscillation

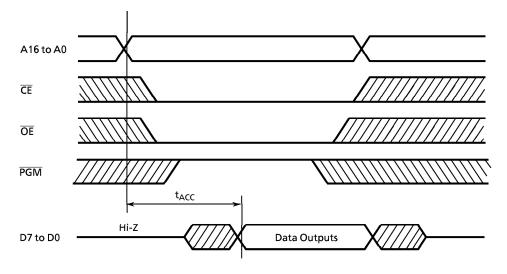
Note: An electrical shield by metal shield on the surface of IC package should be recommendable in order to prevent the device from the high electric fieldstress applied from CRT (Cathode Ray Tube) for continuous reliable operation.

$$(V_{SS} = 0 \text{ V, Topr} = -30 \text{ to } 70^{\circ}\text{C})$$

(1) Read Operation

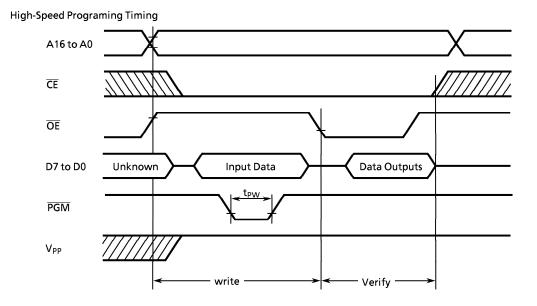
Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Input High Voltage	V _{IH4}		V _{CC} × 0.7	-	V _{CC}	٧
Input Low Voltage	V _{IL4}		0	-	V _{CC} × 0.12	V
Power Supply Voltage	V _{CC}		4.75	5.0	5.25	V
Program Power Supply Voltage	V_{PP}		4.73	3.0	3.23	V
Address Access Time	t _{ACC}	V _{CC} = 5.0 ± 0.25 V	-	1.5tcyc + 300	-	ns

Note: tcyc = 500 ns at 8 MHz



(2) High-Speed Programming Operation

Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Input High Voltage	V _{IH4}		V _{CC} × 0.7	_	V _{CC}	V
Input Low Voltage	V _{IL4}		0	-	V _{CC} × 0.12	V
Power Supply Voltage	V _{CC}		6.0	6.25	6.5	V
Program Power Supply Voltage	V _{PP}		12.5	12.75	13.0	V
Initial Program Pulse Width	t _{PW}	V _{CC} = 6.0 V	0.095	0.1	0.105	ms



Note 1: When V_{cc} power supply is turned on or after, V_{pp} must be increased. When V_{cc} power supply is turned off or before, V_{pp} must be increased.

Note 2: The device must not be set to the EPROM programmer or picked up from it under applying the program voltage (2.75 V \pm 0.5 V = V) to the V_{pp} pin as the device is damaged.